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Application/Control No.	Applicant(s)/Patent under Reexamination
10/072,683	ZUK ET AL.
Examiner	Art Unit
Minh Dieu Nguyen	2137

SEARCHED				
Class	Subclass	Date	Examiner	
726	11-13, 22- 25	3/21/2007	MDN	
709	238-244	3/21/2007	MDN	
713	153, 189	3/21/2007	MDN	
705	51, 54	3/21/2007	MDN	
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Updated inventor name search on EAST (US-PAT; US-PG-PUB; EPO; JPO; DERWENT; IBM-TDB)	3/21/2007	MDN		
Updated text and class search on EAST (US-PAT; US-PG-PUB; EPO; JPO; DERWENT; IBM-TDB)	3/21/2007	MDN		
Every claim has been reviewed for 35 USC non-statutory subject matter	3/21/2007	MDN		
Consulted w/ T. Arani on areas of search	3/21/2007	MDN		